

CoolMOS® Power Transistor

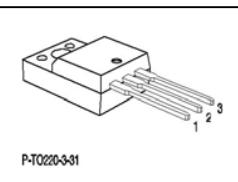
Features

- Worldwide best $R_{DS(on)}$ in TO220 Fullpak
- Ultra low gate charge
- Extreme dv/dt rated
- High peak current capability
- Qualified for industrial grade applications according to JEDEC¹⁾
- Pb-free lead plating; RoHS compliant; Halogen free mold compound

Product Summary

$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max} @ T_j = 25^\circ C$	0.125	Ω
$Q_{g,typ}$	53	nC

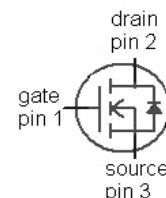
PG-T0220



CoolMOS CP is specially designed for:

- Hard switching SMPS topologies

Type	Package	Ordering Code	Marking
IPA60R125CP	PG-T0220	SP000095275	6R125P



Maximum ratings, at $T_j=25^\circ C$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ²⁾	I_D	$T_C=25^\circ C$	25	A
		$T_C=100^\circ C$	16	
Pulsed drain current ³⁾	$I_{D,pulse}$	$T_C=25^\circ C$	82	
Avalanche energy, single pulse	E_{AS}	$I_D=11 A, V_{DD}=50 V$	708	mJ
Avalanche energy, repetitive t_{AR} ^{3),4)}	E_{AR}	$I_D=11 A, V_{DD}=50 V$	1.2	
Avalanche current, repetitive t_{AR} ^{3),4)}	I_{AR}		11	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=0...480 V$	50	V/ns
Gate source voltage	V_{GS}	static	± 20	V
		AC ($f>1$ Hz)	± 30	
Power dissipation	P_{tot}	$T_C=25^\circ C$	35	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	°C
Mounting torque		M2.5 screws	50	Ncm



IPA60R125CP

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value		Unit
Continuous diode forward current ²⁾	I_S	$T_C=25\text{ }^\circ\text{C}$	25		A
Diode pulse current ³⁾	$I_{S,pulse}$		82		
Reverse diode dv/dt ⁵⁾	dv/dt		15		V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	3.6	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	80	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	°C

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified**Static characteristics**

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$, $I_D=250\text{ }\mu\text{A}$	600	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=1.1\text{ mA}$	2.5	3	3.5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ }^\circ\text{C}$	-	-	2	μA
		$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ }^\circ\text{C}$	-	20	-	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}$, $I_D=16\text{ A}$, $T_j=25\text{ }^\circ\text{C}$	-	0.11	0.125	Ω
		$V_{GS}=10\text{ V}$, $I_D=16\text{ A}$, $T_j=150\text{ }^\circ\text{C}$	-	0.30	-	
Gate resistance	R_G	$f=1\text{ MHz}$, open drain	-	2.1	-	Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{GS}=0 \text{ V}, V_{DS}=100 \text{ V}, f=1 \text{ MHz}$	-	2500	-	pF
Output capacitance	C_{oss}		-	120	-	
Effective output capacitance, energy related ⁶⁾	$C_{o(er)}$	$V_{GS}=0 \text{ V}, V_{DS}=0 \text{ V}$	-	110	-	
Effective output capacitance, time related ⁷⁾	$C_{o(tr)}$	to 480 V	-	300	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=400 \text{ V}, V_{GS}=10 \text{ V}, I_D=16 \text{ A}, R_G=3.3 \Omega$	-	15	-	ns
Rise time	t_r		-	5	-	
Turn-off delay time	$t_{d(off)}$		-	50	-	
Fall time	t_f		-	5	-	

Gate Charge Characteristics

Gate to source charge	Q_{gs}	$V_{DD}=400 \text{ V}, I_D=16 \text{ A}, V_{GS}=0 \text{ to } 10 \text{ V}$	-	12	-	nC
Gate to drain charge	Q_{gd}		-	18	-	
Gate charge total	Q_g		-	53	70	
Gate plateau voltage	$V_{plateau}$		-	5.0	-	V

Reverse Diode

Diode forward voltage	V_{SD}	$V_{GS}=0 \text{ V}, I_F=16 \text{ A}, T_j=25^\circ \text{C}$	-	0.9	1.2	V
Reverse recovery time	t_{rr}	$V_R=400 \text{ V}, I_F=I_S, di_F/dt=100 \text{ A}/\mu\text{s}$	-	430	-	ns
Reverse recovery charge	Q_{rr}		-	9	-	μC
Peak reverse recovery current	I_{rrm}		-	42	-	A

¹⁾ J-STD20 and JESD22

²⁾ Limited only by maximum temperature

³⁾ Pulse width t_p limited by $T_{j,max}$

⁴⁾ Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR} \cdot f$.

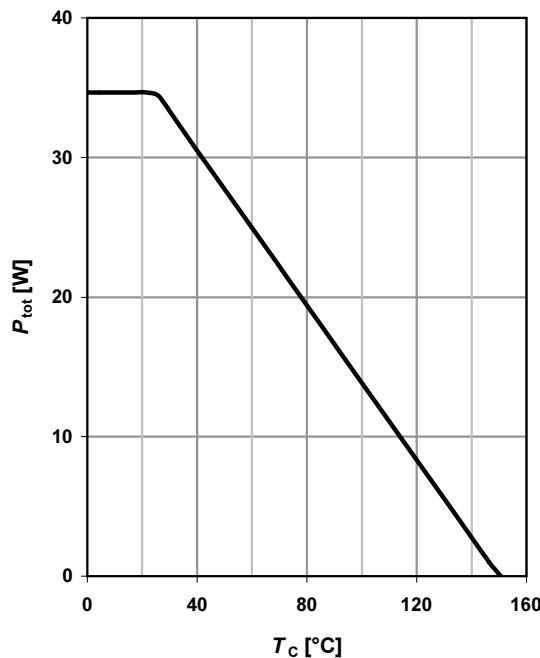
⁵⁾ $I_{SD} \leq I_D, di/dt \leq 200 \text{ A}/\mu\text{s}, V_{DClink}=400 \text{ V}, V_{peak} < V_{(BR)DSS}, T_j < T_{j,max}$, identical low-side and high side switch.

⁶⁾ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

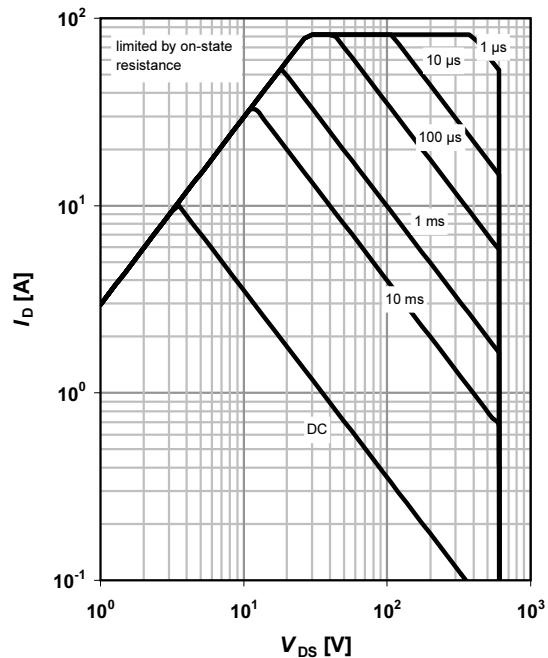
⁷⁾ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

1 Power dissipation

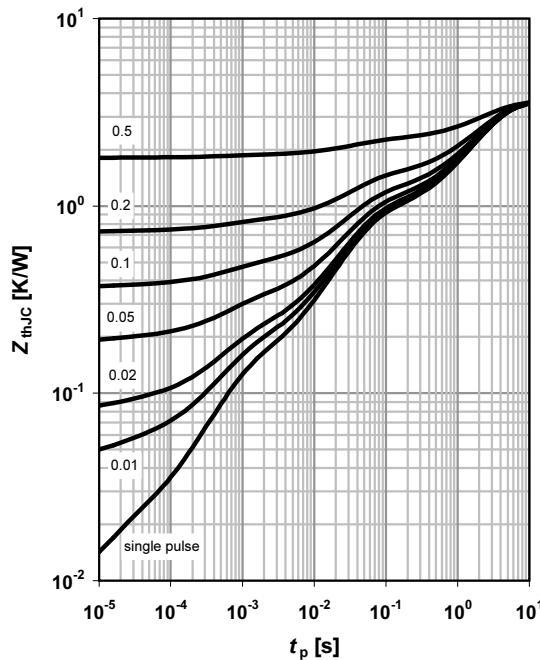
$$P_{\text{tot}} = f(T_C)$$


2 Safe operating area

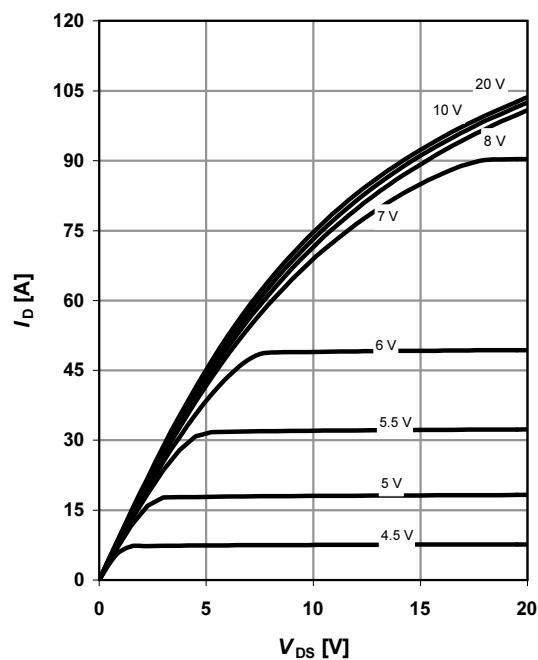
$$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D = 0$$

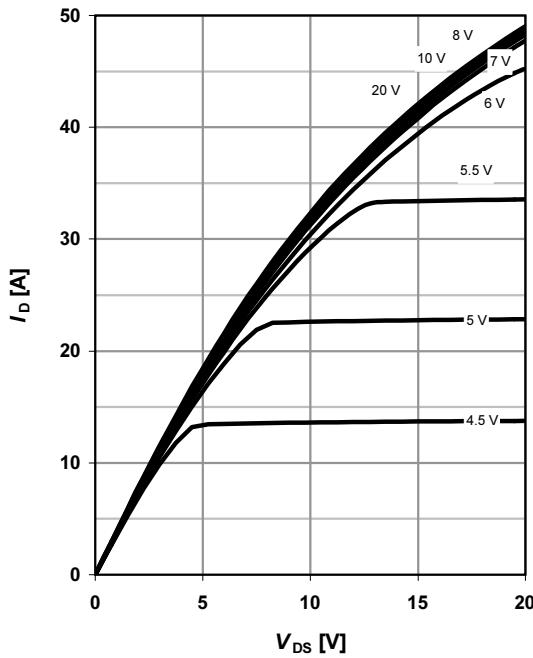
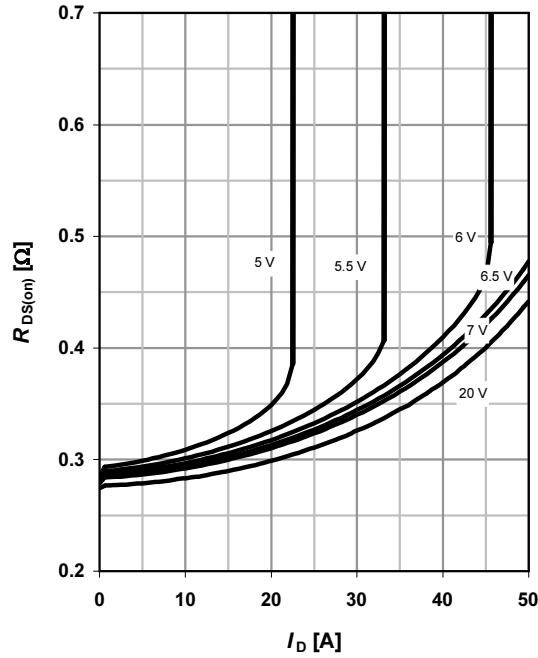
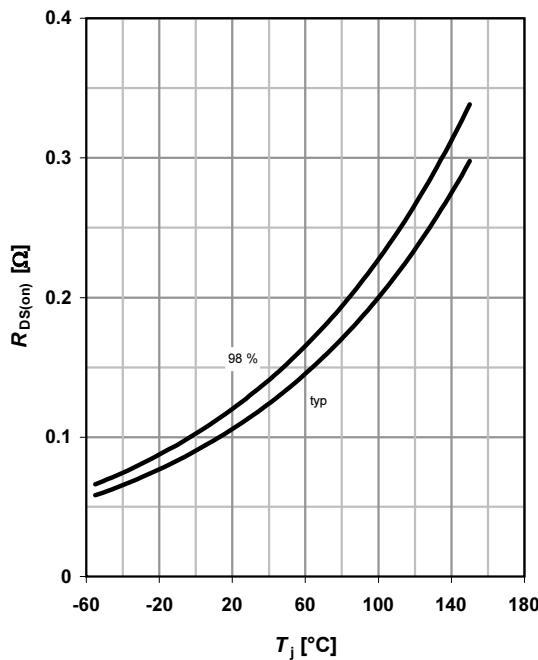
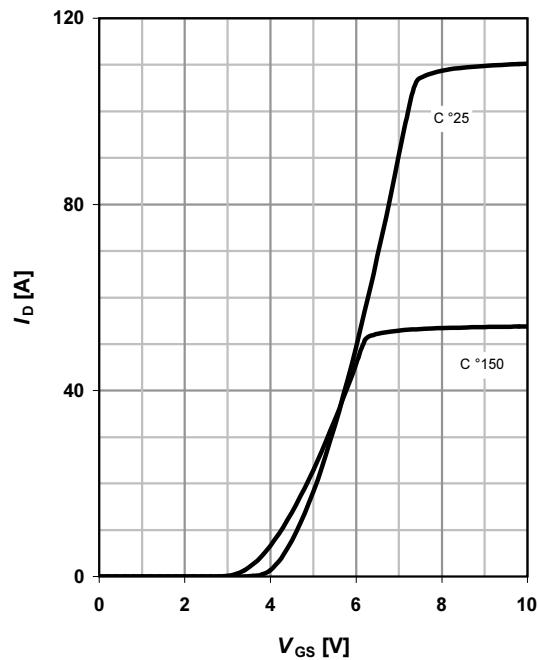
 parameter: t_p

3 Max. transient thermal impedance

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

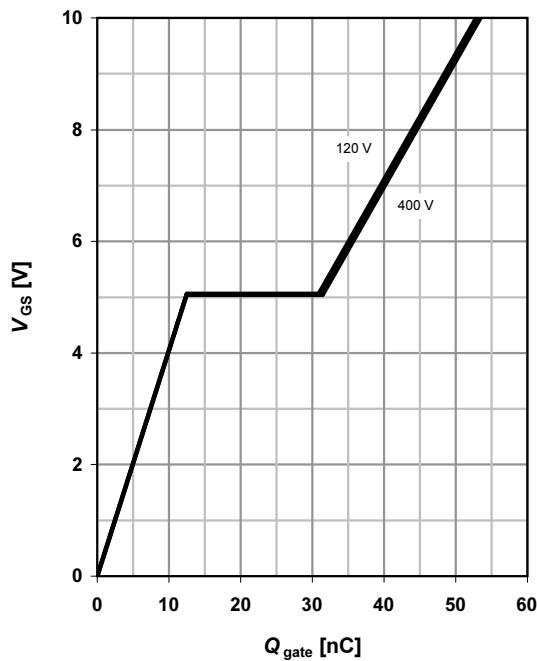
 parameter: $D = t_p/T$

4 Typ. output characteristics

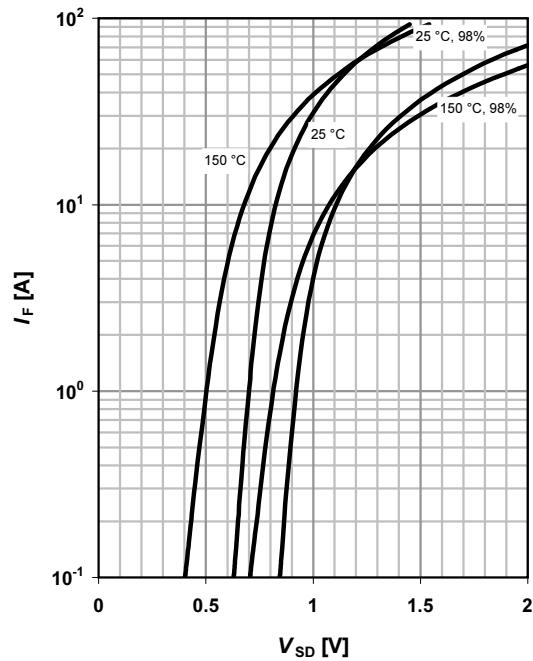
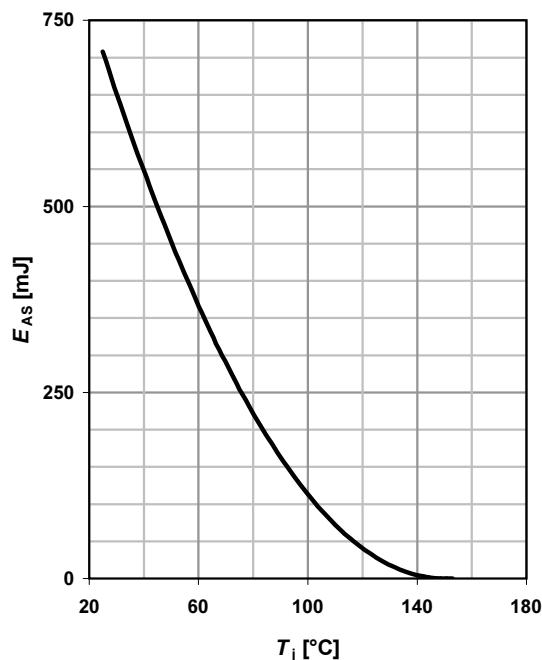
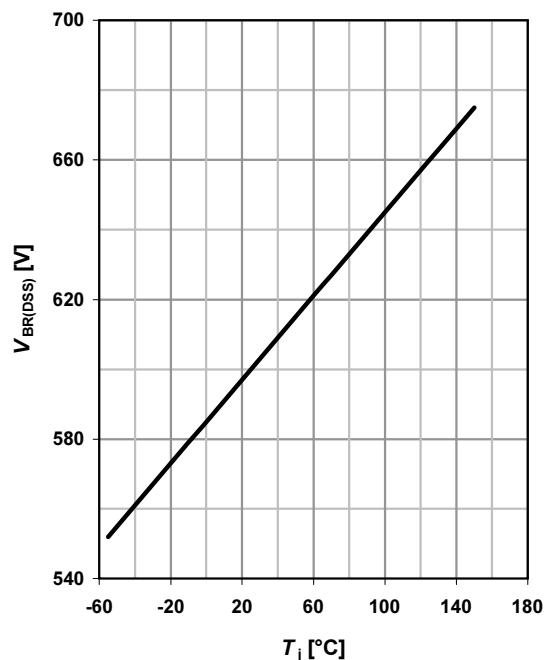
$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

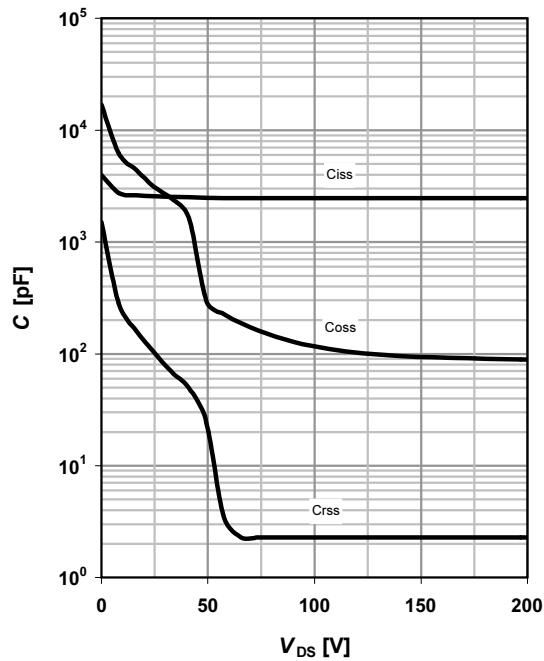
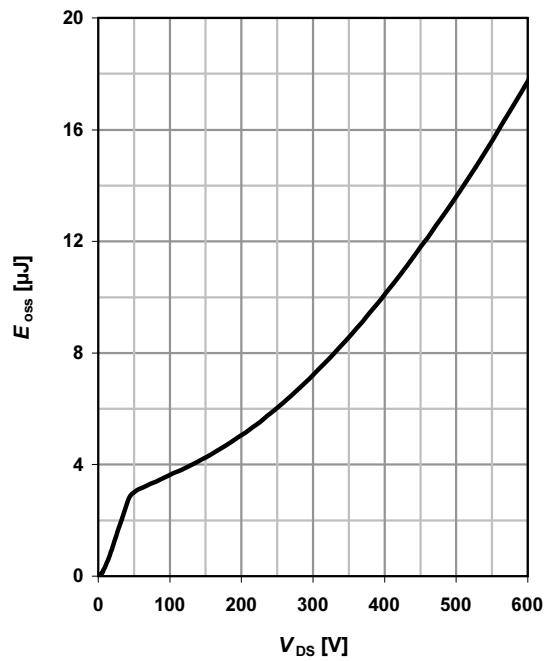
 parameter: V_{GS}


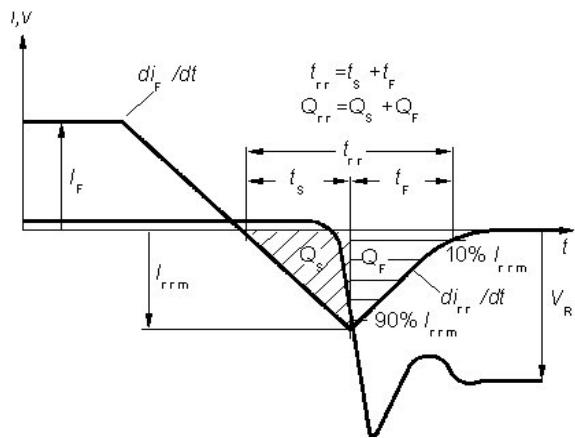
5 Typ. output characteristics
 $I_D = f(V_{DS})$; $T_j = 150 \text{ }^\circ\text{C}$
parameter: V_{GS} 
6 Typ. drain-source on-state resistance
 $R_{DS(on)} = f(I_D)$; $T_j = 150 \text{ }^\circ\text{C}$
parameter: V_{GS} 
7 Drain-source on-state resistance
 $R_{DS(on)} = f(T_j)$; $I_D = 16 \text{ A}$; $V_{GS} = 10 \text{ V}$

8 Typ. transfer characteristics
 $I_D = f(V_{GS})$; $|V_{DS}| > 2|I_D|R_{DS(on)max}$
parameter: T_j 

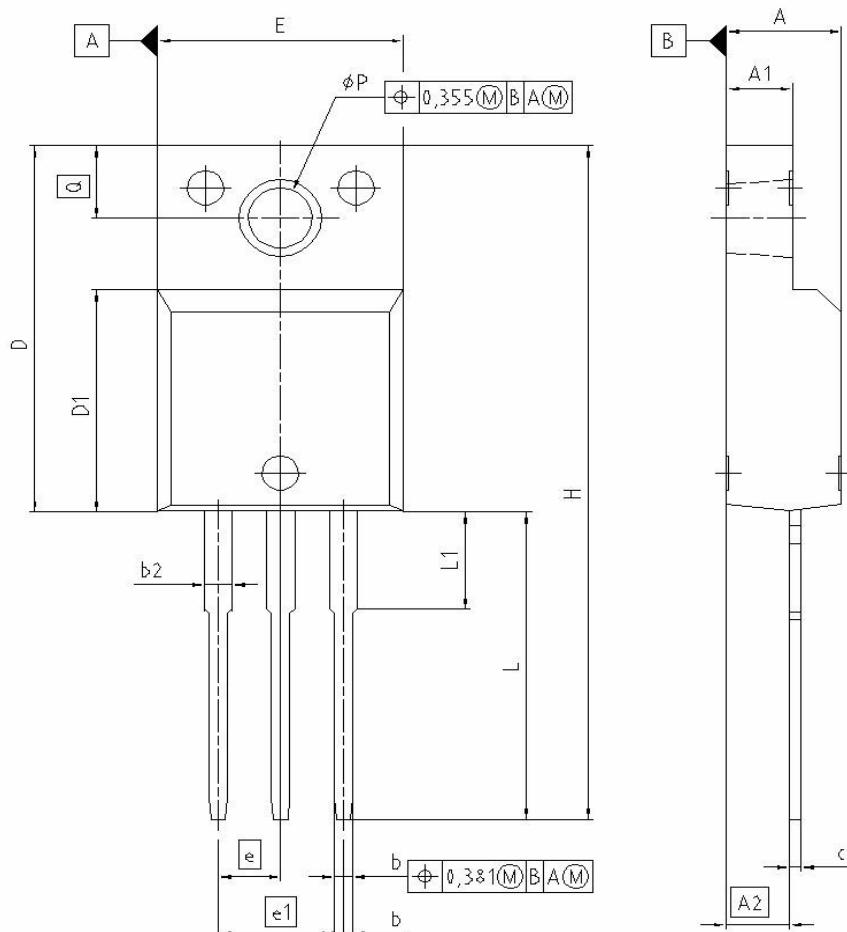
9 Typ. gate charge
 $V_{GS} = f(Q_{gate})$; $I_D = 16 \text{ A}$ pulsed

parameter: V_{DD}

10 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$

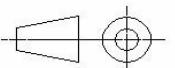
parameter: T_j

11 Avalanche energy
 $E_{AS} = f(T_j)$; $I_D = 11 \text{ A}$; $V_{DD} = 50 \text{ V}$

12 Drain-source breakdown voltage
 $V_{BR(DSS)} = f(T_j)$; $I_D = 0.25 \text{ mA}$


13 Typ. capacitances
 $C = f(V_{DS}) ; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

14 Typ. Coss stored energy
 $E_{oss} = f(V_{DS})$


Definition of diode switching characteristics


PG-T0220-3-31/T0220-3-11: Outline/ Fully isolated package (2500VAC; 1 minute)


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.572	4.826	0.180	0.190
A1	2.573	2.827	0.101	0.111
A2	2.514	2.616	0.099	0.103
b	0.649	0.776	0.025	0.030
b2	1.143	1.509	0.045	0.059
c	0.449	0.627	0.017	0.027
D	15.863	16.117	0.624	0.634
D1	9.554	9.808	0.376	0.386
E	10.373	10.627	0.408	0.418
e	2.540		0.100	
e1	5.080		0.200	
N	3		3	
H	29.463	29.717	1.160	1.170
L	13.473	13.727	0.530	0.540
L1	3.175	3.429	0.125	0.135
dP	2.949	3.025	0.119	0.116
Q	3.149	3.251	0.124	0.128

REFERENCE	
SCALE	0 2.5 0 2.5 5mm
EUROPEAN PROJECTION	
	
ISSUE DATE	17-08-2005
FILE	TO220_2



IPA60R125CP

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Infineon Technologies AG
81726 Munich, Germany
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